



Dependability, Power, and Performance Trade-off on a Multicore Processor

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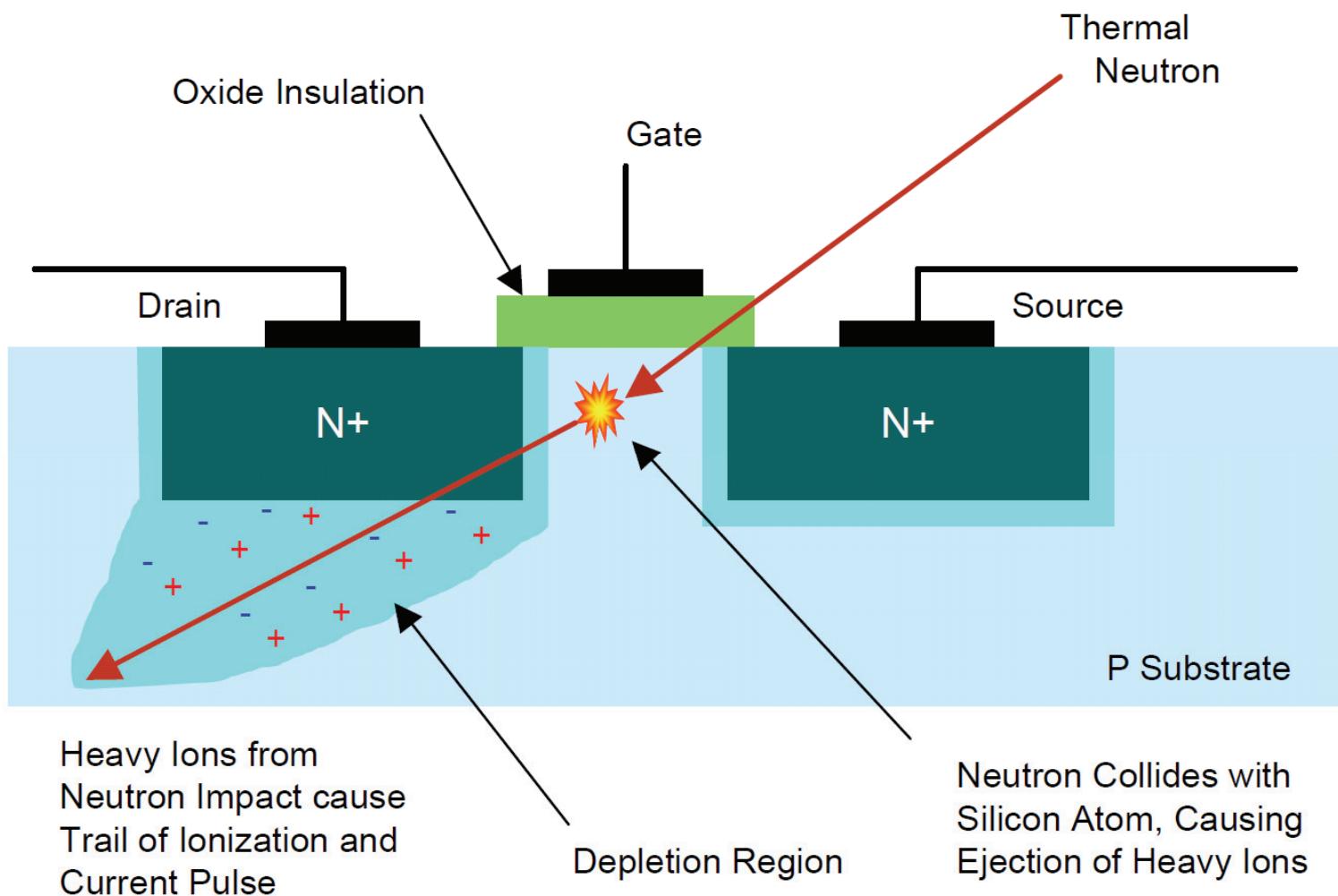
Outline

- What is soft errors?
- Multiple clustered core processor (MCCP)
- Power-performance trade-off
- Evaluation
- Conclusion



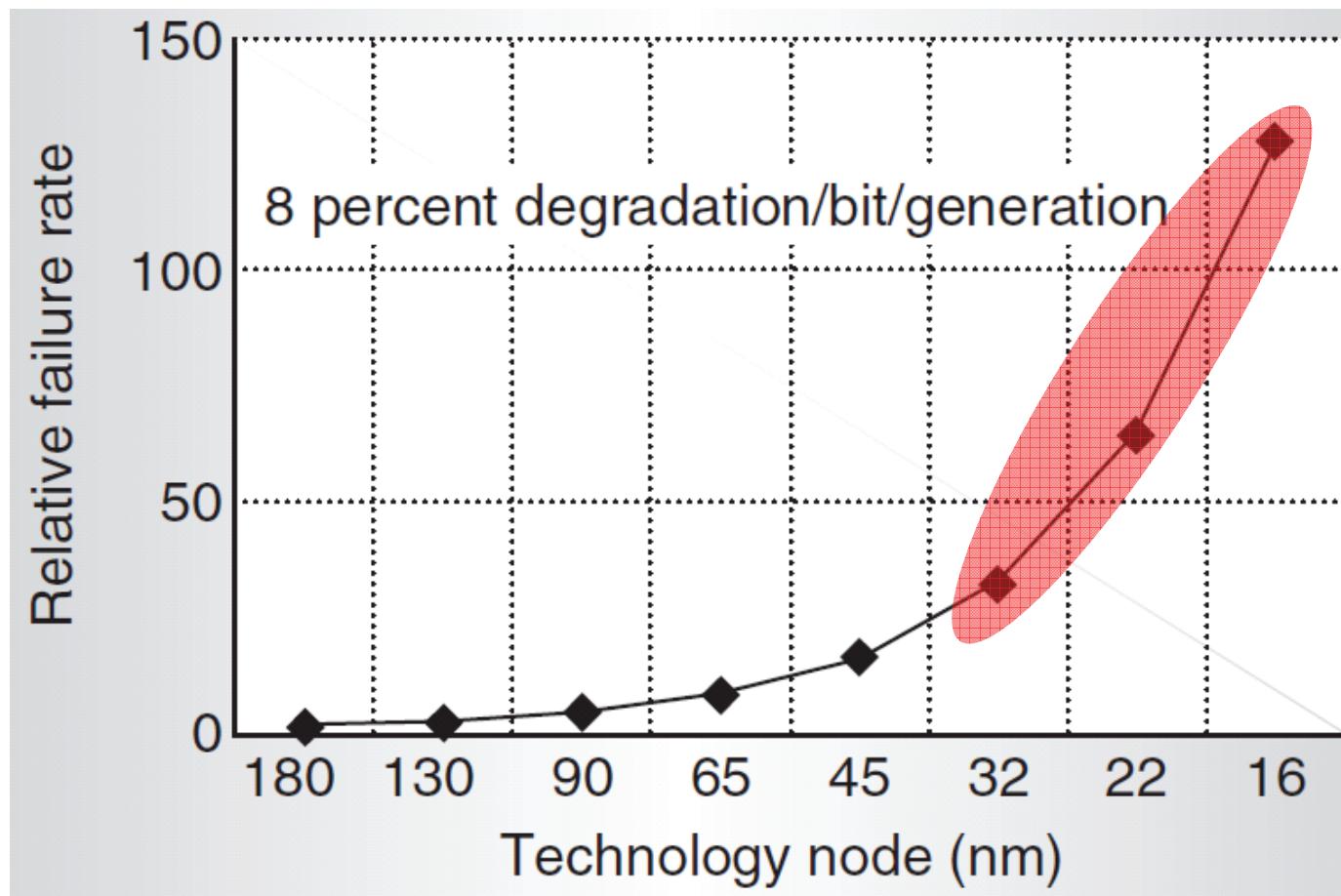
What is soft errors?

- Soft errors are random events which occur when various noise sources cause an incorrect event



Increasing soft error problem

- Advanced semiconductor technologies increase soft error rate





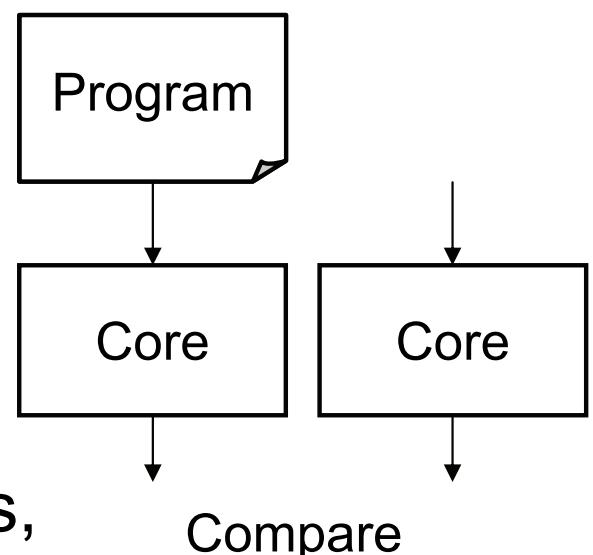
Redundant threading (RT)

- Redundant execution is utilized
 - Space redundancy
 - Time redundancy
 - Focus on detecting soft errors (transient)
 - Error recovery is out of scope



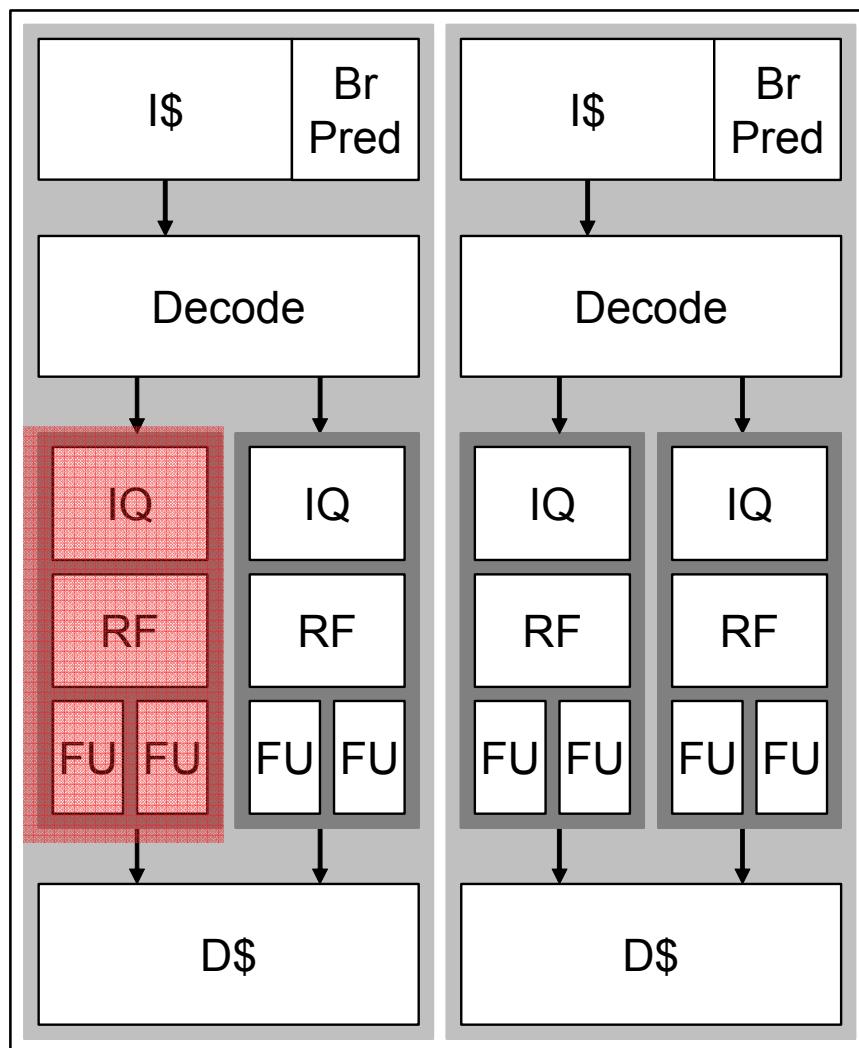
Redundant threading (RT)

- Redundant execution is utilized
 - Space redundancy
 - Time redundancy
- Space redundancy
 - Thread-level redundancy
 - Popularity of multicore processors,
 - high performance
 - High power consumption
- Multiple clustered core processor
 - Considering power performance trade-off





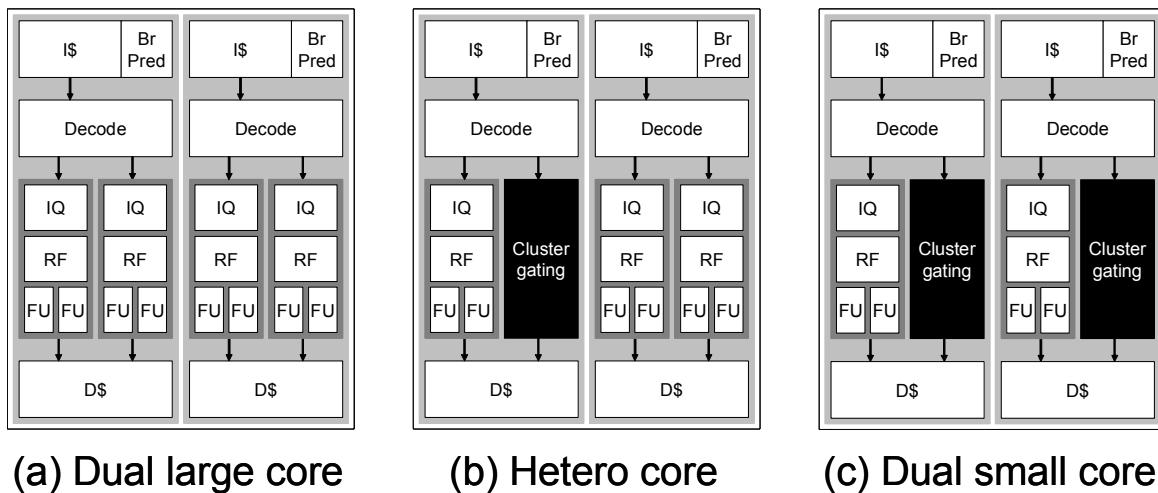
Multiple clustered core processor



- Homogeneous
- Clustered cores
 - Datapath clusters
 - Configurable



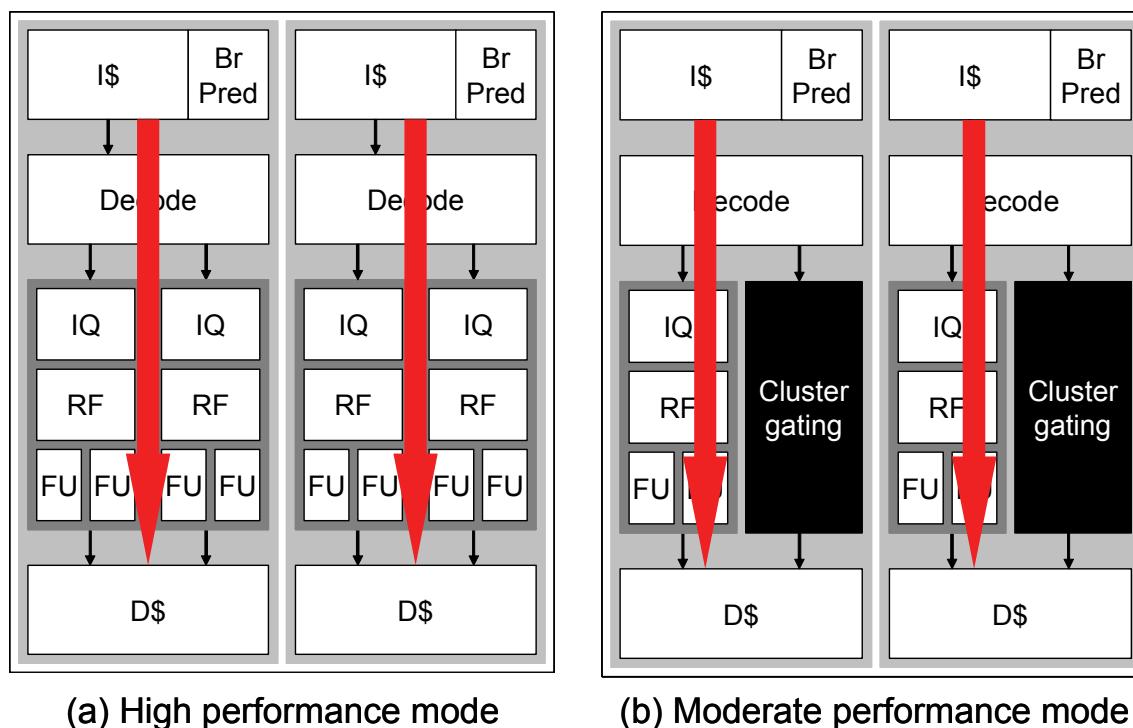
Power-performance trade-off



- Cluster gating
 - Different scales and different configurations
- Consideration on trade-off between power and performance
 - Providing just required performance achieves power reduction



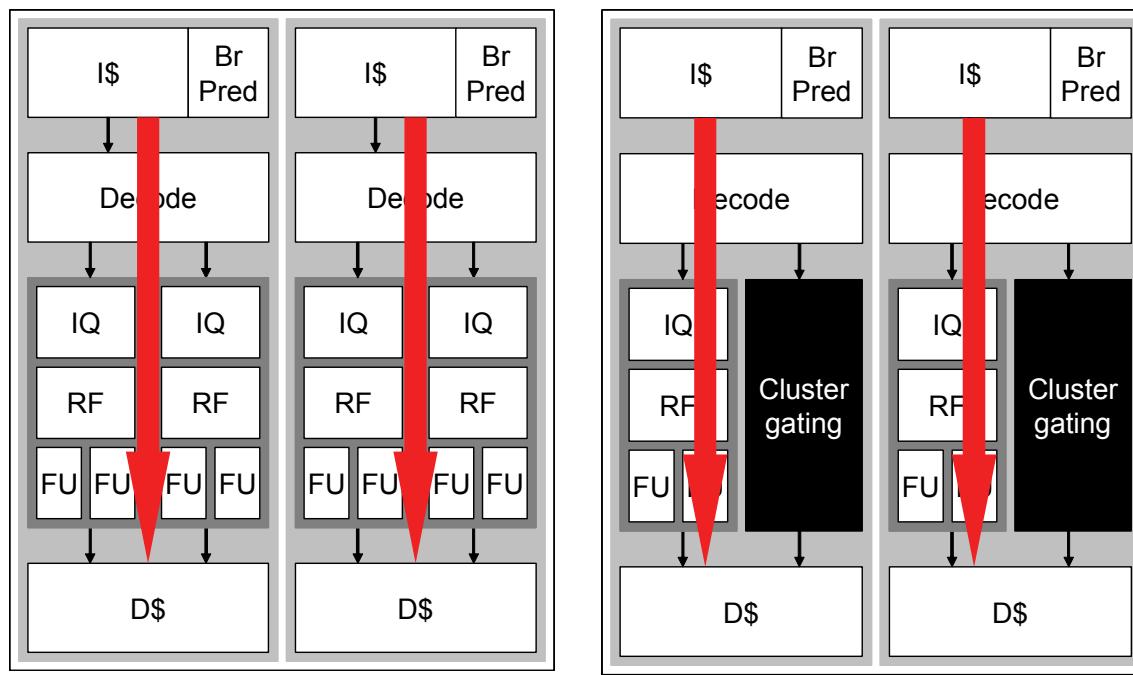
Pwr-perf on dependable proc.



- High performance mode
 - Power consumption is high
- Moderate performance mode
 - Power consumption is low



Pwr-perf on dependable proc.



- High performance mode

i How do we determine the mode?

- - Power consumption is low

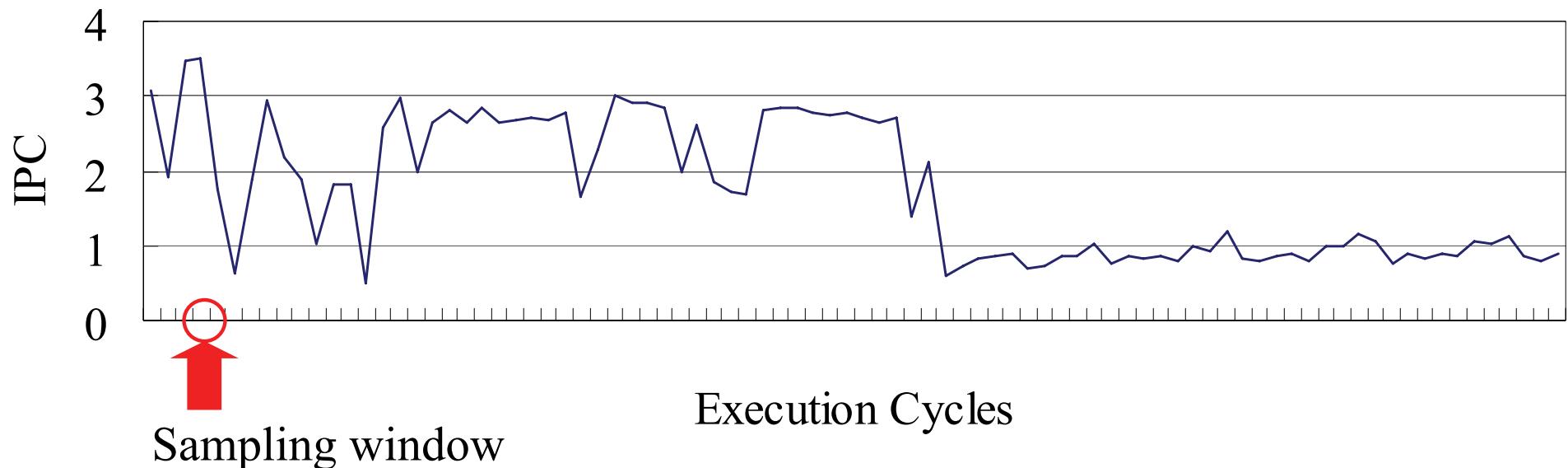


How do we determine mode?

- Annotation-based
 - A programmer marks how important every instruction block is and tells it to HW using annotations
- OS-based
 - OS marks the importance of every instruction block using some metric; ex. deadline time
- HW-based
 - HW transparently evaluates the importance of every instruction block



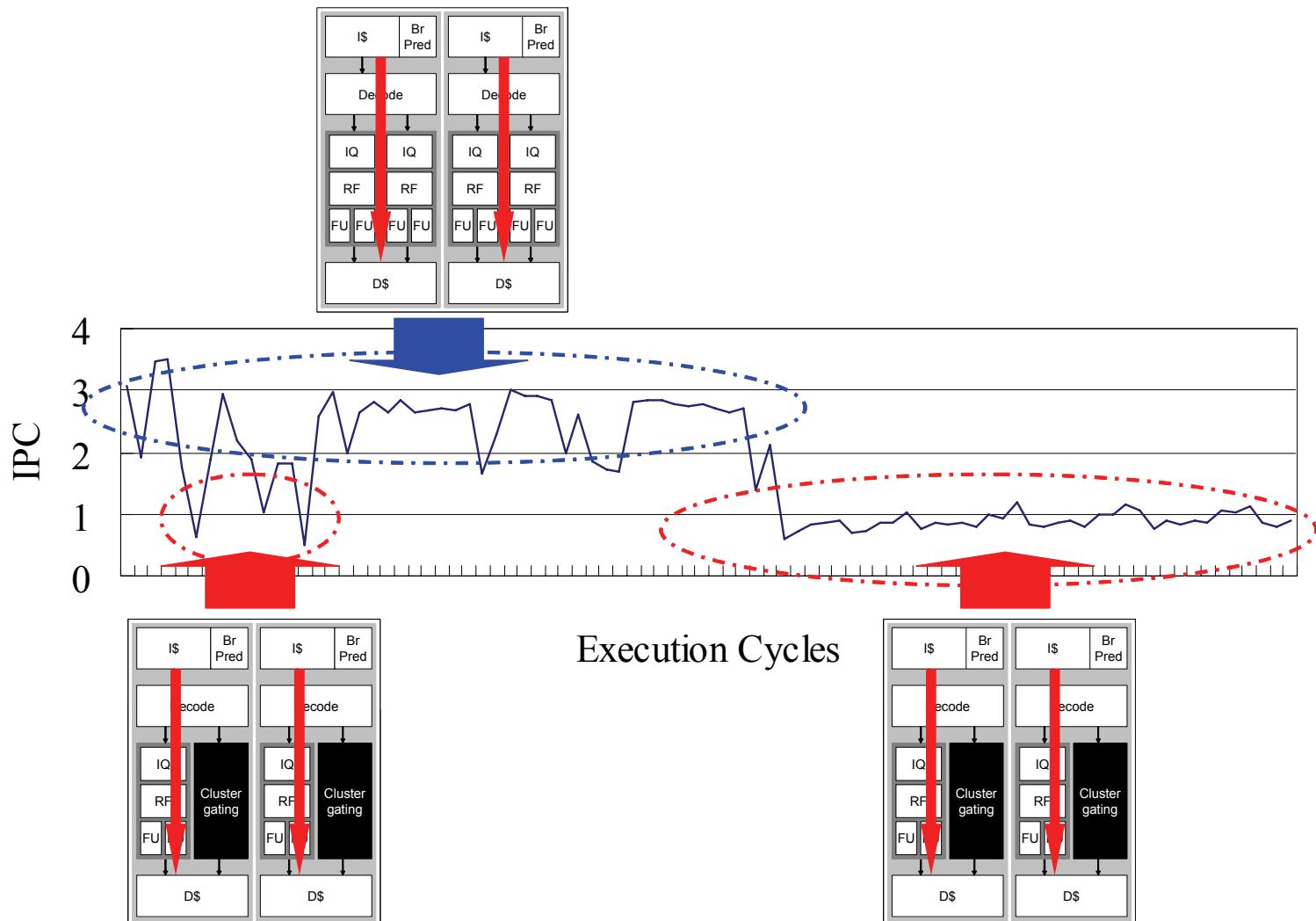
Issue IPC variation



- Issue IPC changes by more than a factor of 2
- The variations can be used to determine the mode

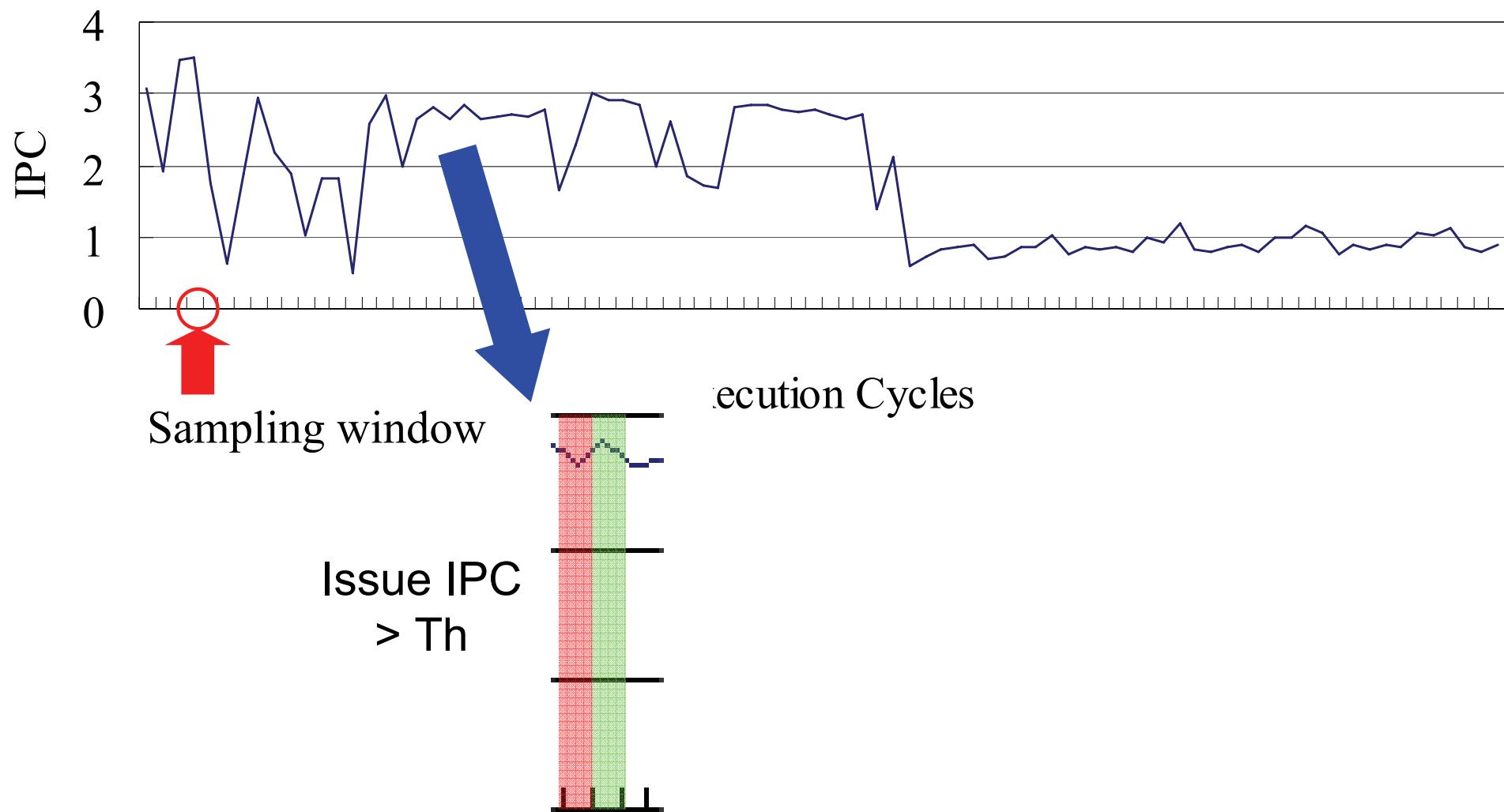


IPC-directed mode selection



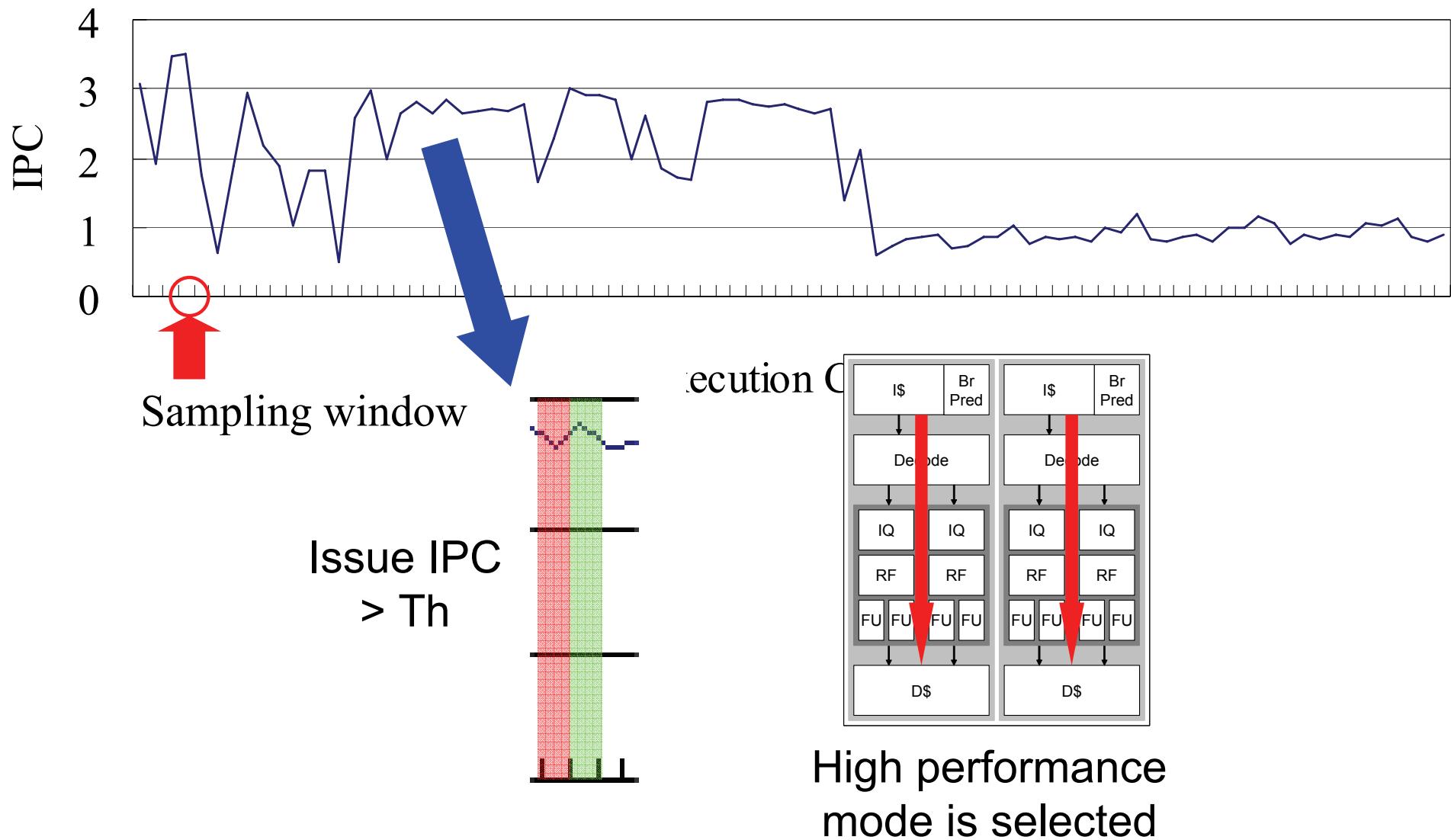


Future IPC prediction





Future IPC prediction





Methodology

- SimpleScalar/PISA
- Dual dual-cluster core MCCP
- Mode switch threshold
 - 2.0: High -> Moderate
 - 1.6: Moderate -> High
- Benchmark
 - SPEC2K
 - MediaBench
- Sampling window
 - 100, 1,000, 10,000

Fetch width	8 instructions
L1 instruction cache	16K, 2-way, 1 cycle
Branch predictor	1K-gshare + 512-BTB
Dispatch width	4 instructions
Instruction window size	16 entries / cluster
Issue width	2 instructions / cluster
Commit width	4 instructions / cluster
Integer ALUs	2 units / cluster
Integer multipliers	2 units / cluster
Floating ALUs	2 units / cluster
Floating multipliers	2 units / cluster
L1 data cache ports	1 port / cluster
L1 data cache	16K, 2-way, 1 cycle
Unified L2 cache	512K, 2-way, 10 cycles
Memory	Infinite, 100 cycles



Upset rate estimation

- Upset rate is estimated as a product of area and soft error rate per bit
- Shared components are not included for estimation
- High : Moderate = 100 : 72

16K L1 data cache	2.6
16K L1 instruction cache	2.6
TLB	4.4
Fetch unit	1.3
Branch predictor	3.2
Decoder	1.7
OOO execution unit	10.1 / cluster
Register files	2.9 / cluster
Functional units	6.5 / cluster
Misc	2.4
Routing	26.4
512 L2 cache	110.0
Misc	6.1
Coherence unit	6.3
I/O	13.7



Power assumption

- Power is estimated using 21264 power consumption
- High : Moderate = 100 : 81

Global Clock Network	32%
Instruction Issue Units	18%
Caches	15%
Floating Execution Units	10%
Integer Execution Units	10%
Memory Management Unit	8%
I/O	5%
Miscellaneous Logic	2%

Table 2: Alpha 21264 Power Components

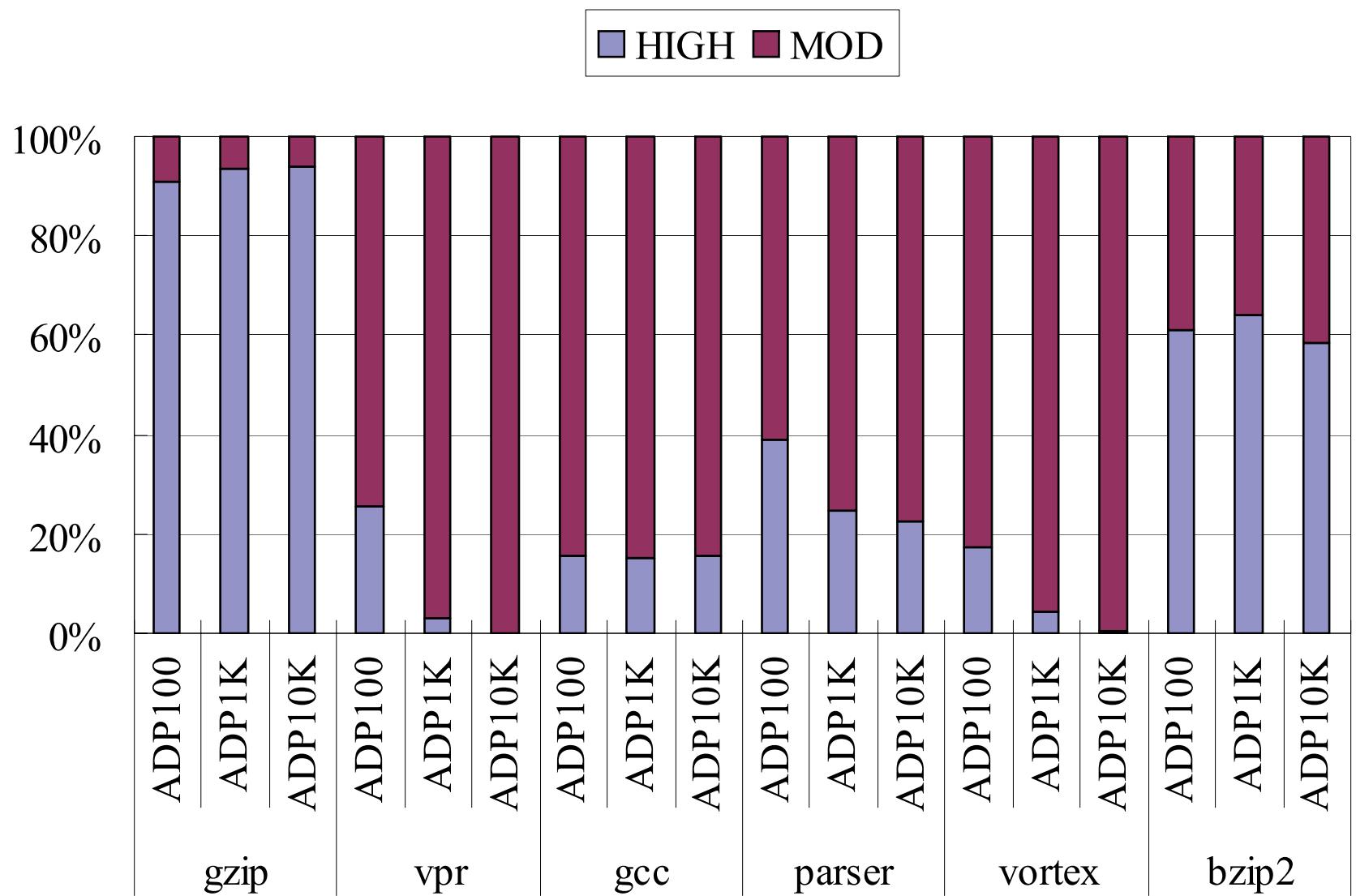


Metric

- To evaluate the trade-off between power, performance, and dependability, a new metric is required
- EDP (energy-delay product) is a popular metric for power-performance trade-off.
- Upset rate is a popular metric for dependability
- We propose to product EDP and upset rate
 - EDUP (energy, delay, and upset-rate product)

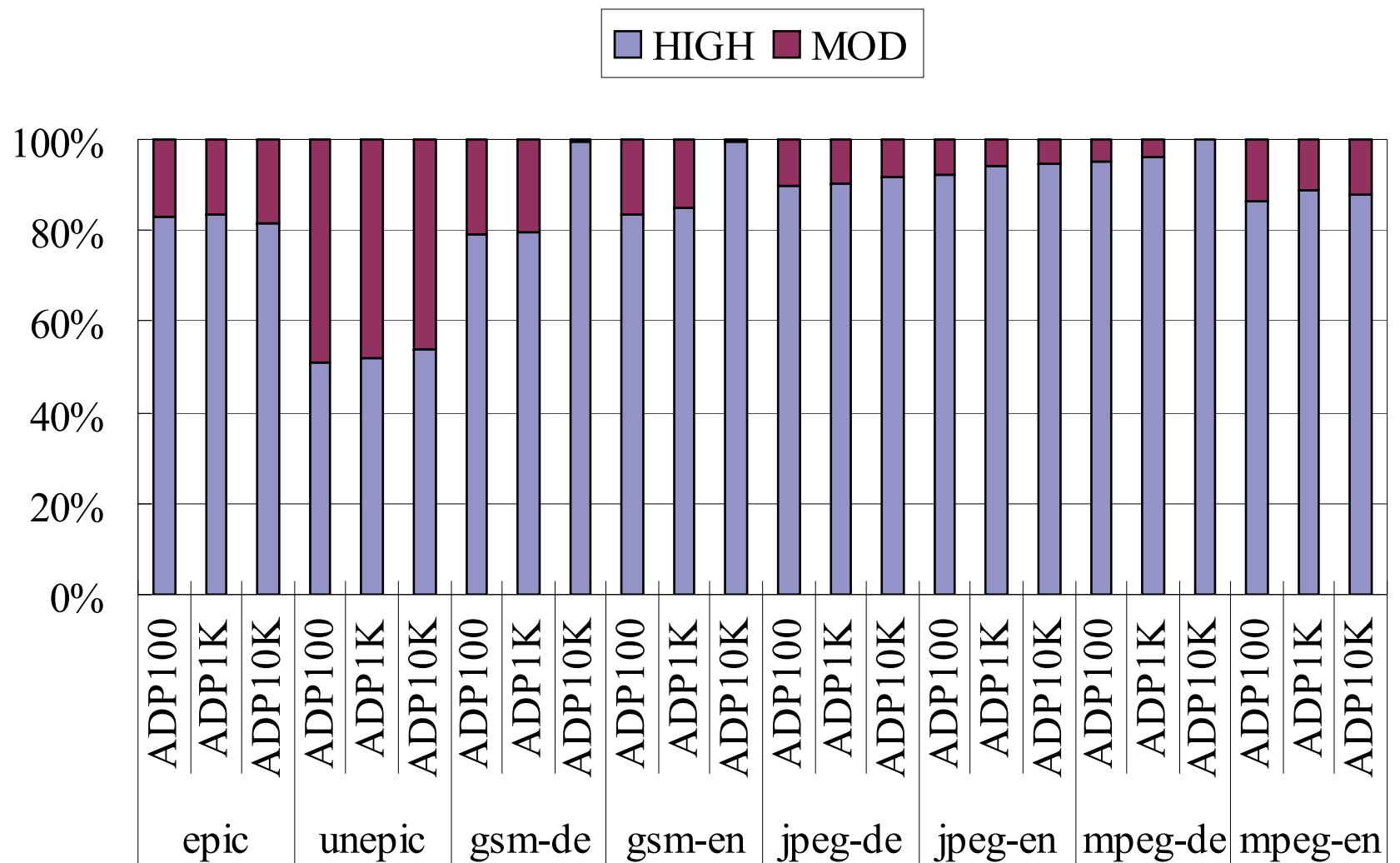


Breakdown of dependability mode



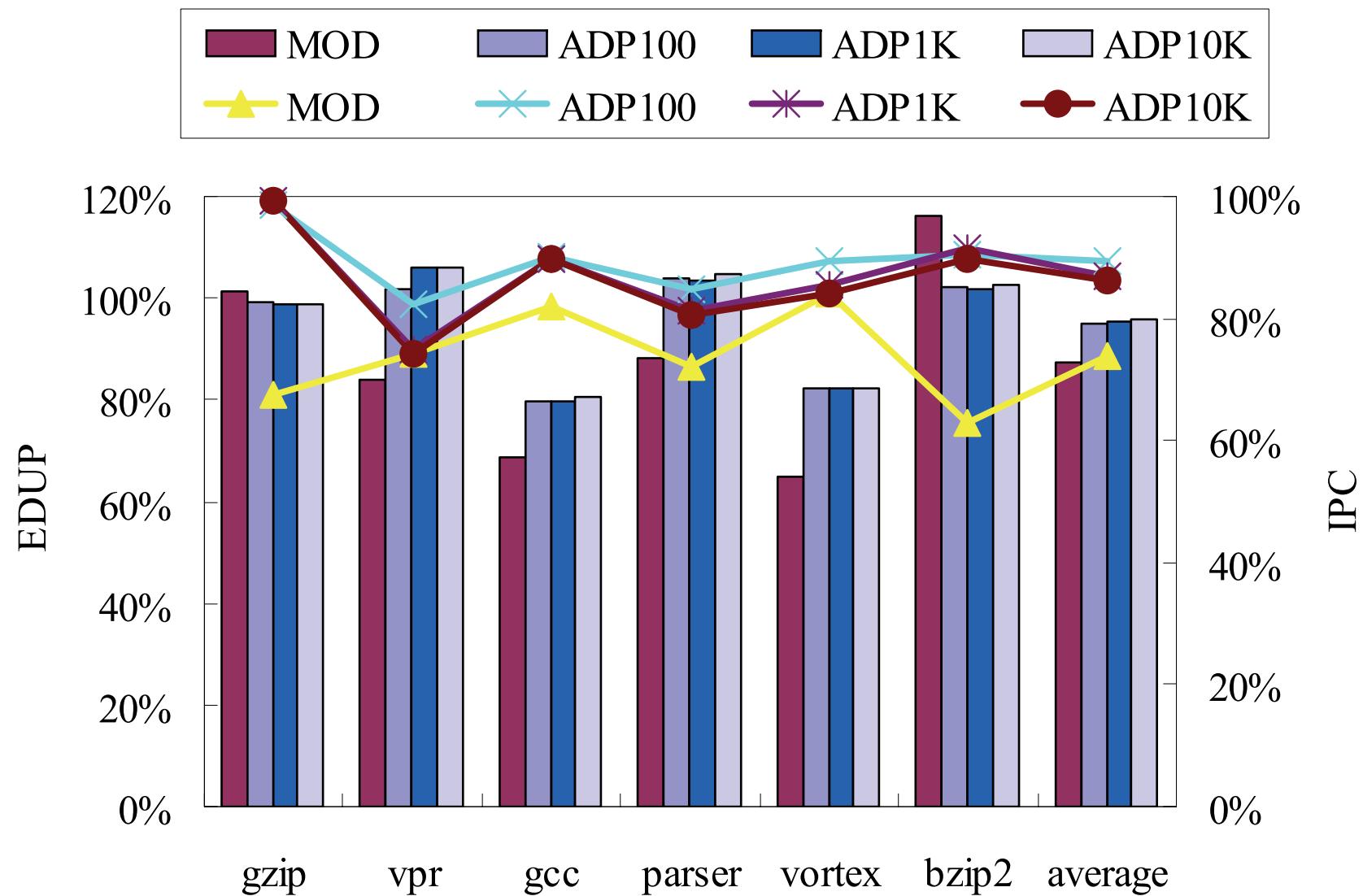


Breakdown of dependability mode



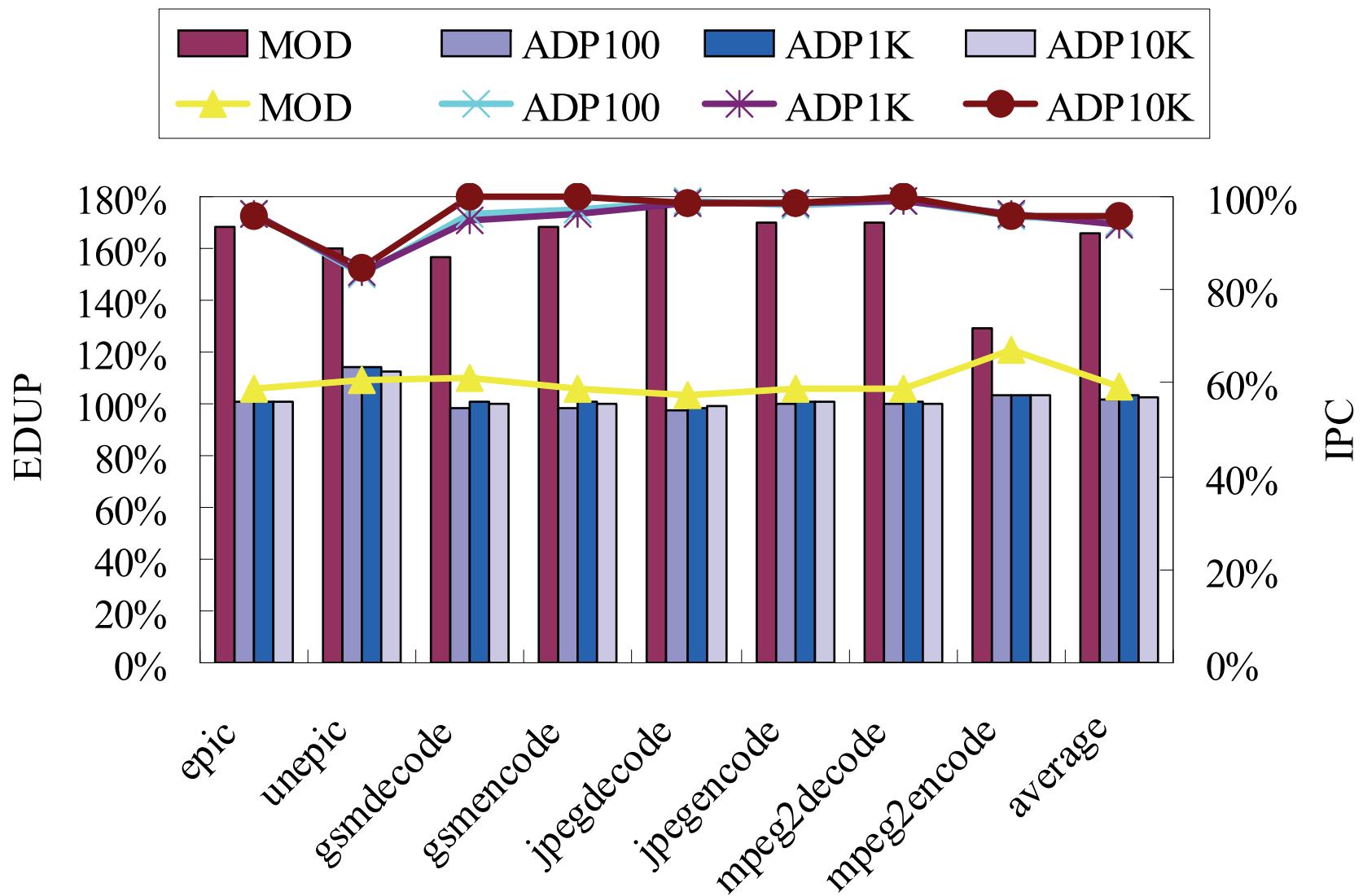


Relative IPC and EDUP





Relative IPC and EDUP





Conclusions

- RT is widely utilized for soft error tolerance, but it consumes much power
- We proposed an adaptable RT, named MCCP
 - It has high- and moderate-performance modes for considering dependability, power, and performance trade-off
- We also proposed EDUP as a metric for evaluating the trade-off
- Detailed simulation showed MCCP improved EDUP by up to 21%



Dependability, Power, and Performance Trade-off on a Multicore Processor

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